Notice	of References	Cited
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Ī	Application/Control No.	Applicant(s)/Pater	nt Under
	10/575,083	Reexamination KIKUCHI ET AL.	
	Examiner	Art Unit	
	JONATHAN SAMPLE	4184	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,559,938	09-1996	Van Roekel et al.	345/441
*	В	US-2003/0220735	11-2003	Nimura, Mitsuhiro	701/208
*	С	US-5,297,051	03-1994	Arakawa et al.	701/200
*	D	US-5,974,876	11-1999	Hijikata et al.	73/178R
*	Е	US-6,356,835	03-2002	Hayashi et al.	701/208
*	F	US-7,010,567	03-2006	Mori, Daishi	709/203
*	G	US-6,927,774	08-2005	Yano, Fumiko	345/469
*	Н	US-6,643,585	11-2003	McGovern, John	701/211
*	Т	US-6,565,610	05-2003	Wang et al.	715/210
	J	US-			
	к	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
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NON DATENT DOCUMENTS

*	* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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